

FORM PTO-1449 US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Atty. Docket No. 86564RLO Customer No. 01333	Serial No. To be assigned 10/643,837
If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee		Applicant: Dustin Winters, et al	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)		Filing Date Herewith	Group 2879

U.S. PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
ab	2002/0186214 ✓	12-12-2002	Siwinski			
	2002/0025419 ✓	02-28-2002	Lee et al			
	4356429 ✓	10-26-1982	Tang			
	5276380 ✓	01-04-1994	Tang			
	5283182 ✓	02-01-1994	Powell et al			
	5405709 ✓	04-11-1995	Littman et al			
	5503910 ✓	04-02-1996	Matsuura et al			
	5550066 ✓	08-27-1996	Tang et al			
	5683823 ✓	11-04-1997	Shi et al			
	5780174 ✓	07-14-1998	Tokito et al			
	6281634 ✓	08-28-2001	Yokoyama			
	6406801 ✓	06-18-2002	Tokito et al			
ab	6456013 ✓	09-24-2002	Komiya et al			

FOREIGN PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
ab	11-288786 ✓	10-19-1999	Japan			X
ab	1182244 ✓	02-27-2002	EPO			X
ab	1187235 ✓	03-13-2002	EPO			X

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
ab	Djurisic et al, Organic microcavity light-emitting diodes with metal mirrors: dependence of the emission wavelength on the viewing angle, Applied Optics Vol. 41, No. 36, Dec. 2002, pgs. 7650-7656					

EXAMINER <i>Dustin Winters</i>	DATE CONSIDERED <i>6/20/05</i>
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

FORM EKC-1449		Atty. Docket No. 86564RLO Customer No. 01333	Serial No. 10/643,837				
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)							
		Filing Date 19 August 2003	Group 2879				
U.S. PATENT DOCUMENTS							
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
af	2003/0107314 A1	06-12-2003	Urabe et al				

FOREIGN PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
af	0616488	09-21-1994	EPO			X
af	2000068069	03-03-2000	Japan			X
af	WO 00/11728	03-02-2000	WO			X
af	2349979	11-15-2000	UK			X

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)	
EXAMINER <i>Asmuth</i>	DATE CONSIDERED <i>6/20/05</i>
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